


Search Notes 	Application/Control No. 10533420	Applicant(s)/Patent Under Reexamination CHEN ET AL.
	Examiner Yelena G Gakh, Ph.D.	Art Unit 1797

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SEARCH NOTES		
Search Notes	Date	Examiner
EAST (attached), search for PCT/US03/35012, inventors' names search, Google	11/21/2008	YG

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